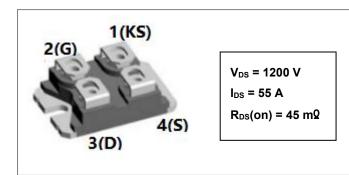




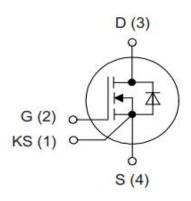
S2M0040120N-1 1200V SIC POWER MOSFET



Description

S2M0040120N-1 is single SiC Power MOSFET packaged in SOT-227 case. The device is a high voltage n-channel enhancement mode MOSFET that has very low total conduction losses and very stable switching characteristics over temperature extremes. The S2M0040120N-1 is ideal for energy sensitive, high frequency applications in challenging environments.

Circuit Diagram



Features

- Positive temperature characteristics, easy to parallel.
- Low on-resistance Typ. RDS(on) = $45m\Omega$.
- Fast switching speed and low switching losses.
- · Very fast and robust intrinsic body diode.
- Process of non-bright Tin electroplatin

Applications

- EV Fast Charging Modules
- EV On Board Chargers
- Solar Inverters
- Online UPS/Industrial UPS
- SMPS (Switch Mode Power Supplies)
- DC-DC Converters
- ESS (Energy Storage Systems)

Maximum Ratings(T=25°C unless otherwise specified)

Characteristics	Symbol	Condition	Max.	Units
Drain Source Voltage	V _{DSS}	V _{GS} = 0V, I _{DS} = 100uA, T _C = 25°C	1200	V
Gate Source Voltage	V _{GSS}	T _C = 25°C, Absolute maximum values, AC (f>1Hz)	-10 to 25	V
Gate Source Voltage	V_{GSOP}	T _C = 25°C Recommended Operational Values	-5 to 20	V
Continuous Drain Current	I _D	V _{GS} = 20V, T _C = 25°C	55	А
	I _D	V _{GS} = 20V, T _C = 100°C	39	А
Pulsed Drain Current	I _{D,pulse}	Pulse width tP limited by T _J max	160	А
Power Dissipation	PD	T _C =25°C, T _J = 175 °C	348	W
SOT-227 Mounting Torque		M4 Screw	1	Nm

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Electrical Characteristics(T=25°C unless otherwise specified)

Characteristics	Symbol	Condition	Min.	Тур.	Max.	Units
Drain Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 100uA	1200			V
0.1. Ti 1.111/."	M	$V_{DS} = V_{GS}$, $I_D = 10$ mA	2.0	2.8	4.0	٧
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 10mA, T _J = 175 °C		1.8		V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 1200V, V _{GS} = 0V		1	100	uA
Gate Source Leakage Current	I _{GSS}	V _{GS} = 20V, V _{DS} = 0V			250	nA
Drain Causes On State Besietenes	Б	V _{GS} = 20V, I _D = 40A		45	52	mΩ
Drain Source On-State Resistance	$R_{DS(on)}$	V _{GS} = 20V, I _D = 40A, T _J = 175 °C		73		mΩ
To a constitution of		V _{DS} = 20 V, I _{DS} = 40 A		10		S
Transconductance	gfs	V _{DS} = 20 V, I _{DS} = 40 A, T _J = 175 °C		12		S
Input Capacitance	C _{ISS}	$V_{GS} = 0V,$ $V_{DS} = 1000V$ $V_{AC} = 25mV$ $f = 1MHz$		1904		pF
Output Capacitance	Coss			108		
Reverse Transfer Capacitance	C _{RSS}			6		
C _{OSS} Stored Energy	Eoss	1 - 1101112		72.9		uJ
Turn-On Switching Energy	Eon	V _{DS} = 800V, V _{GS} = -5/20V		0.25		
Turn-Off Switching Energy	E _{OFF}	I_D =40A, $R_{G(ext)}$ =2.5 Ω , L=99uH		0.05		mJ
Turn-On Delay Time	$t_{d(on)}$	V _{DS} = 800V, V _{GS} = -5/20V		12		
Rise Time	t _r	$I_D = 40A, R_{G(ext)} = 2.5\Omega$		14		
Turn-Off Delay Time	$t_{d(off)}$	Inductive Load Timing relative to VDS Per IEC60747-8-4 pg 83		22		ns
Fall Time	t _f	1 VD3 FEI IEC00/4/-0-4 pg 63		4		
Internal Gate Resistance	R _{G(int)}	f = 1MHz, VAC = 25 mV		2.6		Ω
Gate to Source Charge	Q_{gs}	V _{DS} = 800V, V _{GS} = -5/20V, I _D = 40A		34.3		
Gate to Drain Charge	Q_{gd}	Per IEC60747-8-4 pg 21		32.1		nC
Total Gate Charge	Q_g			92.1		

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Reverse Diode Characteristics:

Characteristics	Symbol	Condition	Тур.	Max.	Units
Diada Farward Valtage	\/	V _{GS} = -5V, I _{SD} = 20A	3.6		V
Diode Forward Voltage	V_{SD}	V _{GS} = -5V, I _{SD} = 20A, T _J =175°C	3.2		V
Continuous Diode Forward Current	ls	T _C =25°C	44		Α
Reverse Recovery Time	t _{rr}	V _{GS} =-5V, I _{SD} =50A, T _J =25°C	43.4		ns
Reverse Recovery Charge	Q_{rr}	V _R =800V	162		nC
Peak Reverse Recovery Current	I_{mm}	dif/dt=1047A/μs	8.1		Α

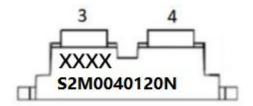
Thermal-Mechanical Specifications:

Characteristics	Symbol	Condition	Specification	Units
Junction Temperature	T_J	-	-55 to +175	°C
Storage Temperature	T_{stg}	-	-55 to +175	°C
Typical Thermal Resistance Junction to Case	R ₀ JC	DC operation	0.43	°C/W
Maximun Thermal Resistance Junction to Ambient	$R_{ hetaJA}$		40	°C/W

Ordering Information:

Device	Package	Shipping
S2M0040120N-1	SOT-227	36pcs /BULK

Marking Diagram



Where XXXXX is YYWWL

S2M = Device Type 0040 = R_{DS}(on)

120 = Reverse Voltage (1200V) N = Package

SSG = SSG
YY = Year
WW = Week
L = Lot Number

Cautions: Molding resin

Epoxy resin UL:94V-0

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Ratings and Characteristics Curves

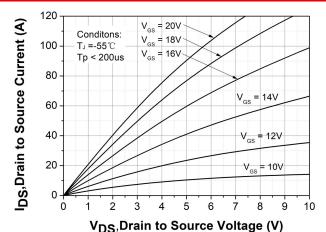


Figure 1. Output Characteristics T_J = -55 °C

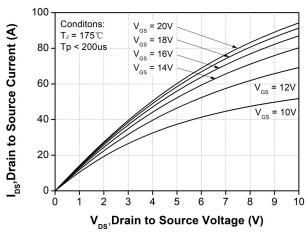


Figure 3. Output Characteristics T_J = 175°C

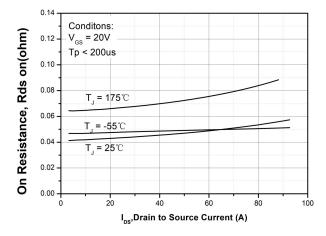


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

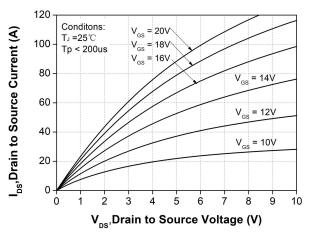


Figure 2. Output Characteristics T_J = 25 °C

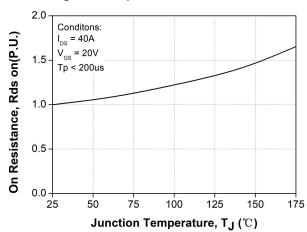


Figure 4. Normalized On-Resistance vs. Temperature

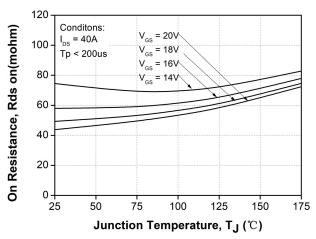


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

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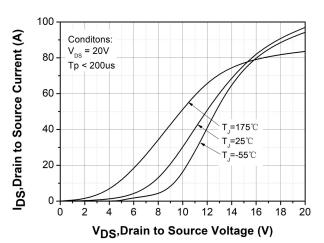


Figure 7. Transfer Characteristic for Various Junction Temperatures

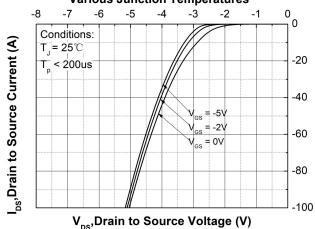


Figure 9. Body Diode Characteristic at T_J = 25 °C

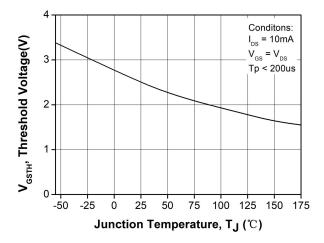


Figure 11. Threshold Voltage vs. Temperature

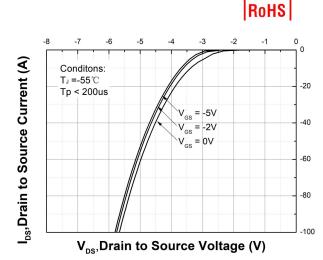


Figure 8. Body Diode Characteristic at T_J = -55 °C

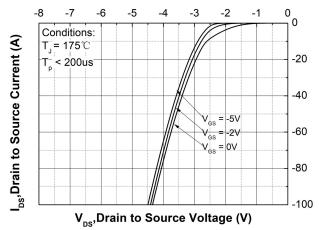


Figure 10. Body Diode Characteristic at T_J = 175 °C

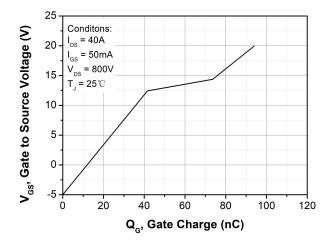


Figure 12. Gate Charge Characteristic

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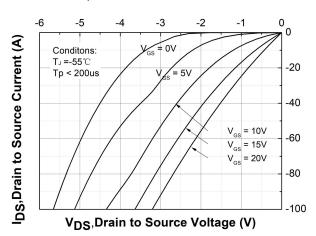


Figure 13. 3rd Quadrant Characteristic at T_J = -55 °C

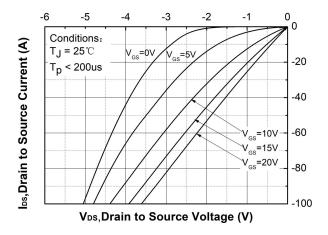


Figure 15. 3rd Quadrant Characteristic at T_J = 175°C

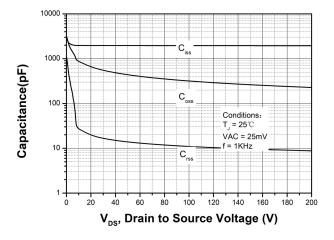


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)



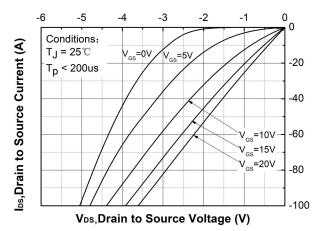


Figure 14. 3rd Quadrant Characteristic at T_J = 25 °C

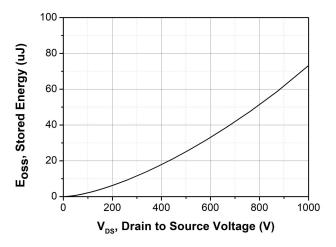


Figure 16. Output Capacitor Stored Energy

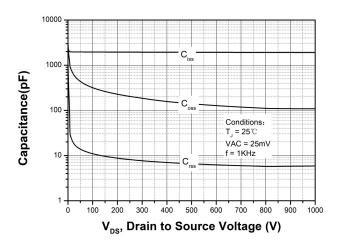


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

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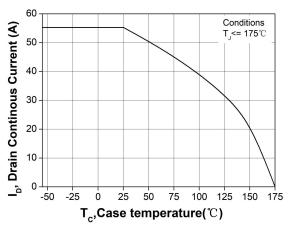


Figure 19. Continuous Drain Current Derating vs.

Case Temperature

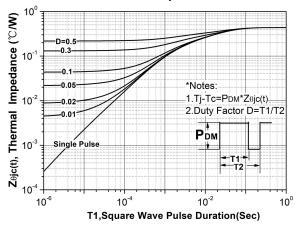


Figure 21. Transient Thermal Impedance (Junction - Case)

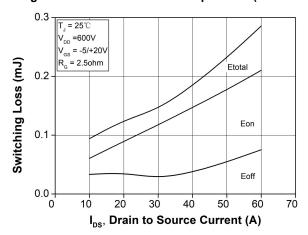


Figure 23. Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 600V)



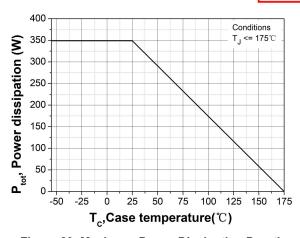


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

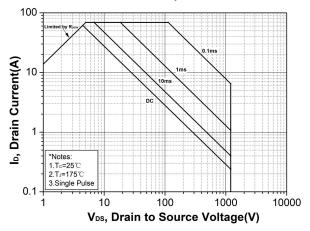


Figure 22. Safe Operating Area

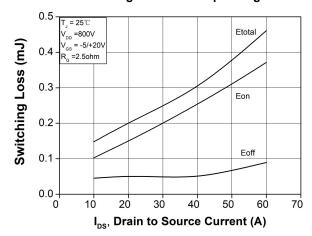


Figure 24. Clamped Inductive Switching Energy vs. Drain Current (V_{DD} = 800V)

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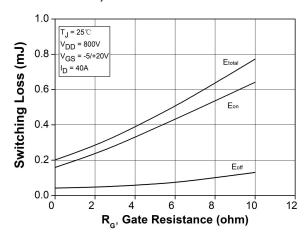


Figure 25. Clamped Inductive Switching Energy vs. R_{G(ext)}

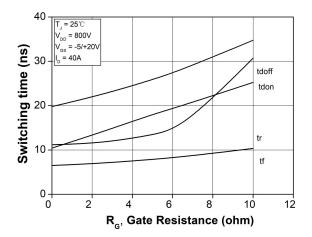


Figure 27. Switching Times vs. R_{G(ext)}

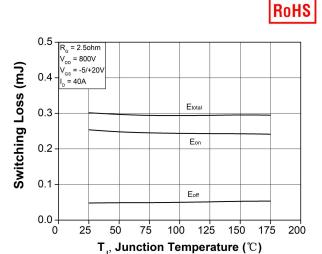


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

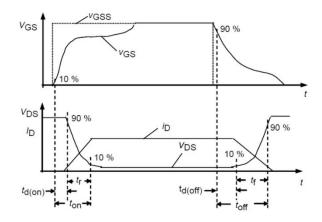
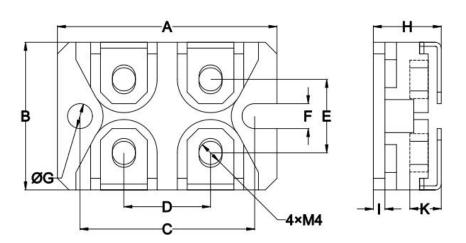


Figure 28. Switching Times Definition





Mechanical Dimensions SOT-227



SYMBOL	Dimensions in millimeters			
	Min.	Max.		
Α	37.8	38.2		
В	24.8	25.2		
С	29.9	30.5		
D	14.5	15.5		
E	12.2	13.2		
F	4.1	4.31		
G	φ4.1	φ4.31		
Н	11	12.5		
I	1.9	2.1		
K	4.3	6.5		

S2M0040120N-1



Technical Data Data Sheet N2743, REV.-



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